

POLYMERIC SPACE-CHARGE ELECTRETS

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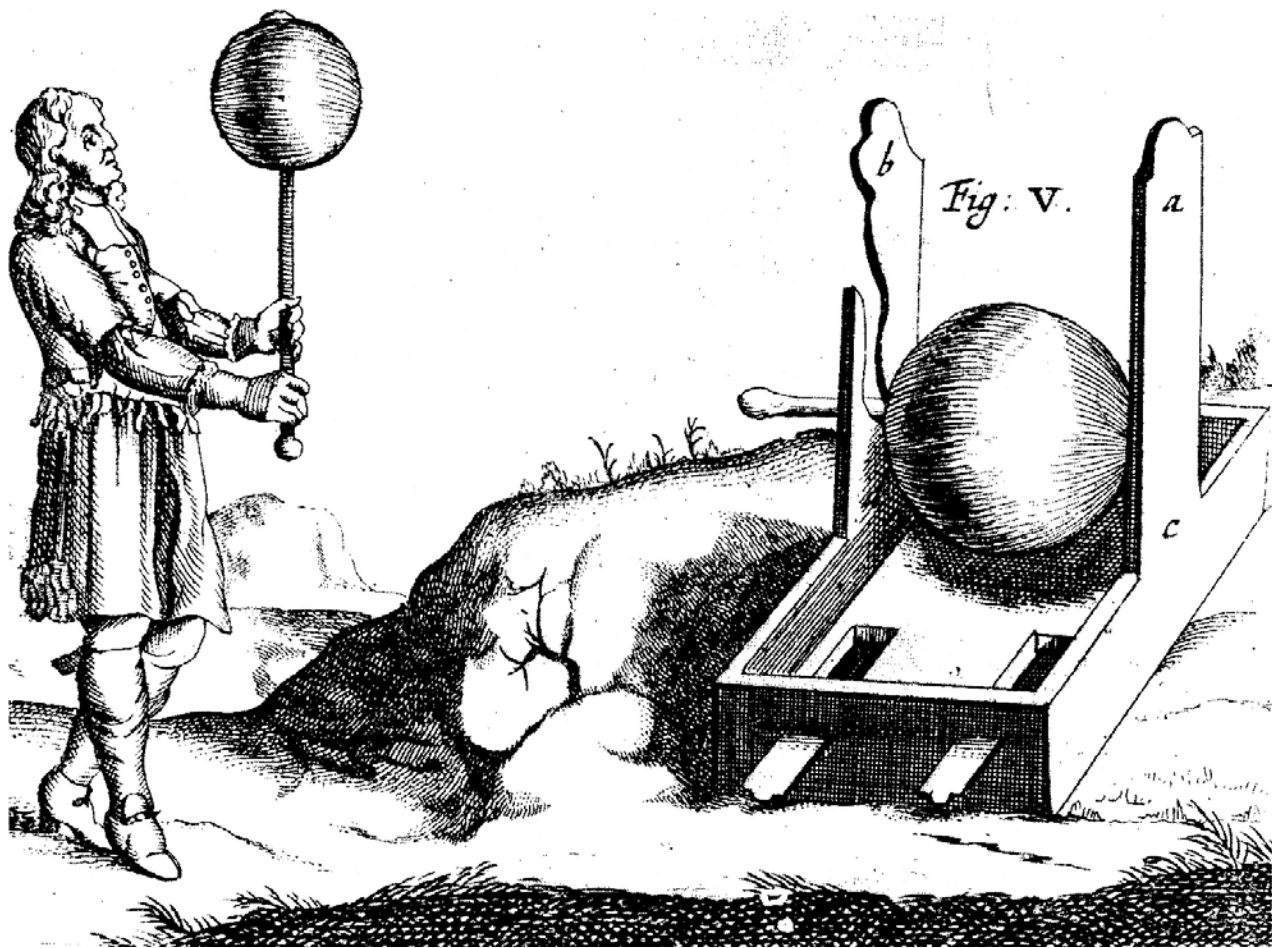
Applied Condensed-Matter Physics

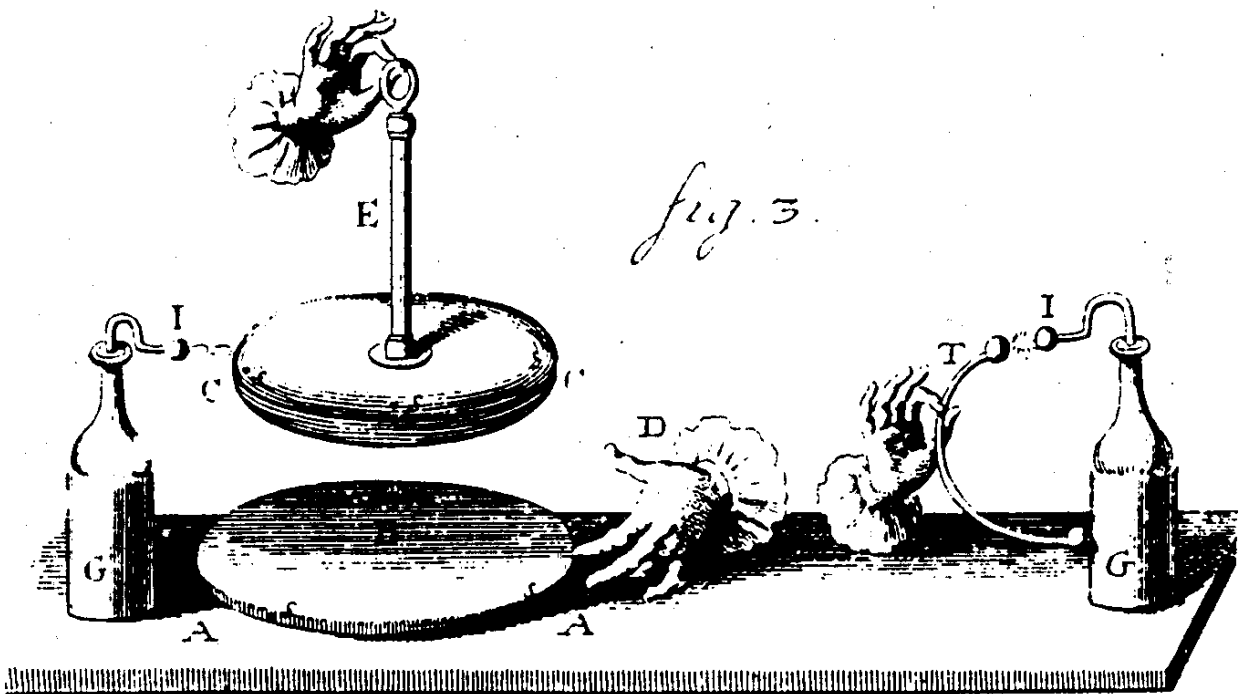
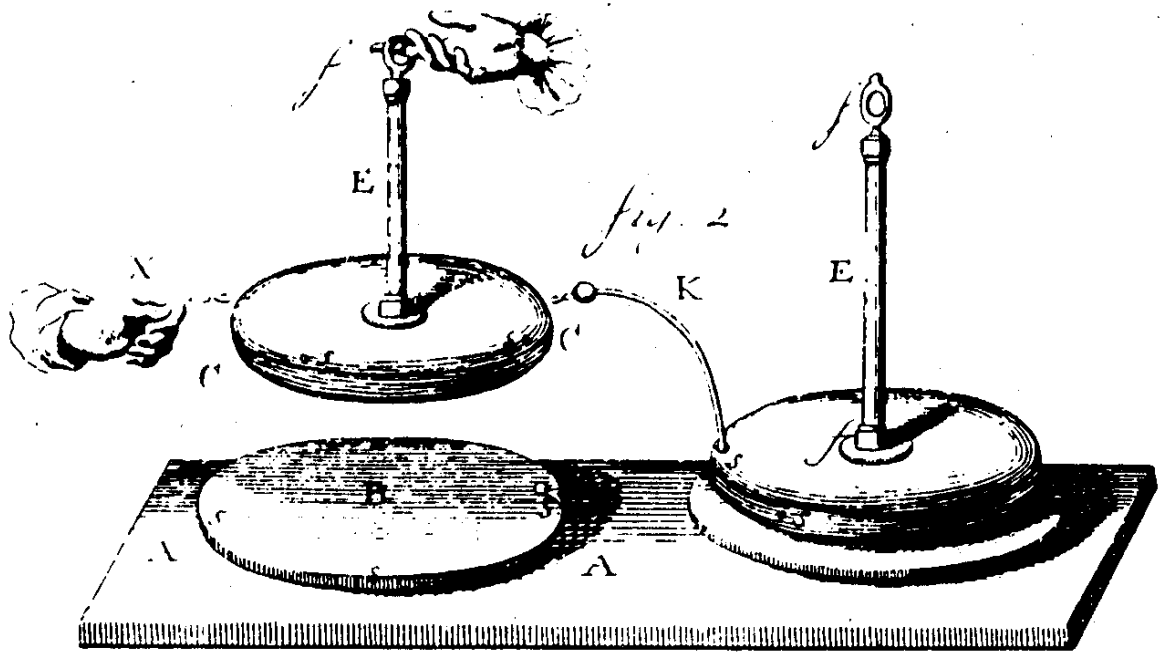
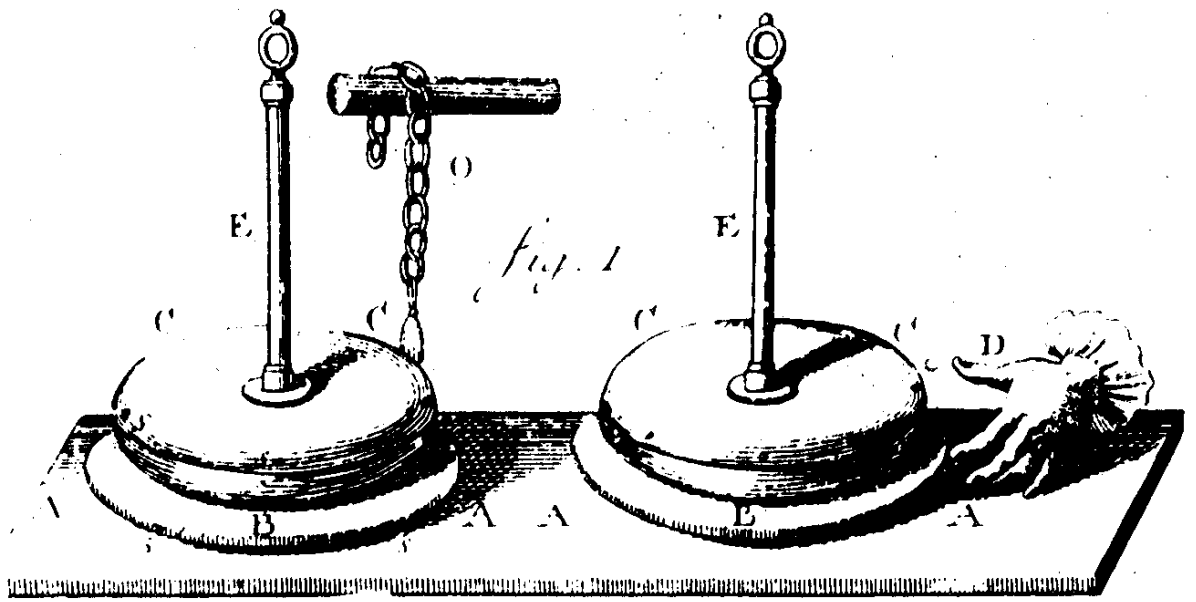
University of Potsdam, Germany

1. A little bit of history and some introduction:
Electrophore or space-charge electret?
2. Charge-storing polymers for electret applications:
Typical materials and essential requirements
3. Acoustical and thermal charge-probing techniques:
Looking inside without cutting the polymer open
4. The mystery of charge-trapping mechanisms:
Chemical trapping, physical trapping or both?
5. Conclusions and outlook

School on Polymers and Composites for Microelectronics and Robotics

Applied Condensed-Matter Physics, Univ. of Potsdam

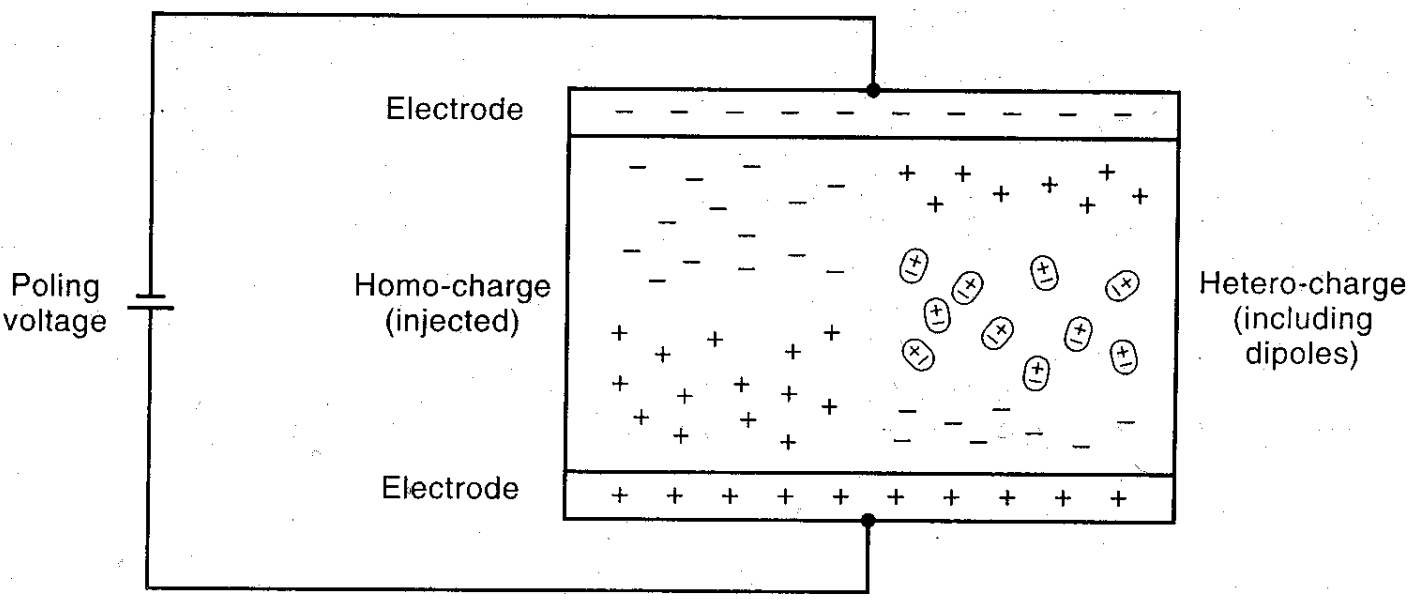




Short History of Electret Science until 1900

- Thales of Miletus (~640–546 B.C.): Knowledge about the attractive force of magnets and amber
- William Gilbert (1544–1603): Clear distinction between “magnets” and (di-)“electrics”
- Otto von Guericke (1602–1686): Electrification of sulfur and demonstration of electric forces
- Stephen Gray (1666–1736): Discovery of several electret materials and of electrical conduction
- Petrus van Musschenbroek (1692–1761) and Ewald Georg von Kleist (~1700–1748): Discovery of the “Leiden” or “Kleist” jar (glass capacitor)
- Benjamin Franklin (1706–1790): Theory of the “electrical fire” (including charge conservation)
- Franz Ulrich Theodosius Aepinus (1724–1802): Qualitative theory of electro- and magnetostatics
- Johan Carl Wilcke (1732–1796) and Alessandro Volta (1745–1827): Invention of “electrophorus”
- Charles-Augustin Coulomb (1736–1806): Law of the forces between electric charges on bodies
- Oliver Heaviside (1850–1925): First proposal of the name “electret” (in analogy to “magnet”)

(Injected) homocharge (left) and (separated) heterocharge (right) in a polymer electret



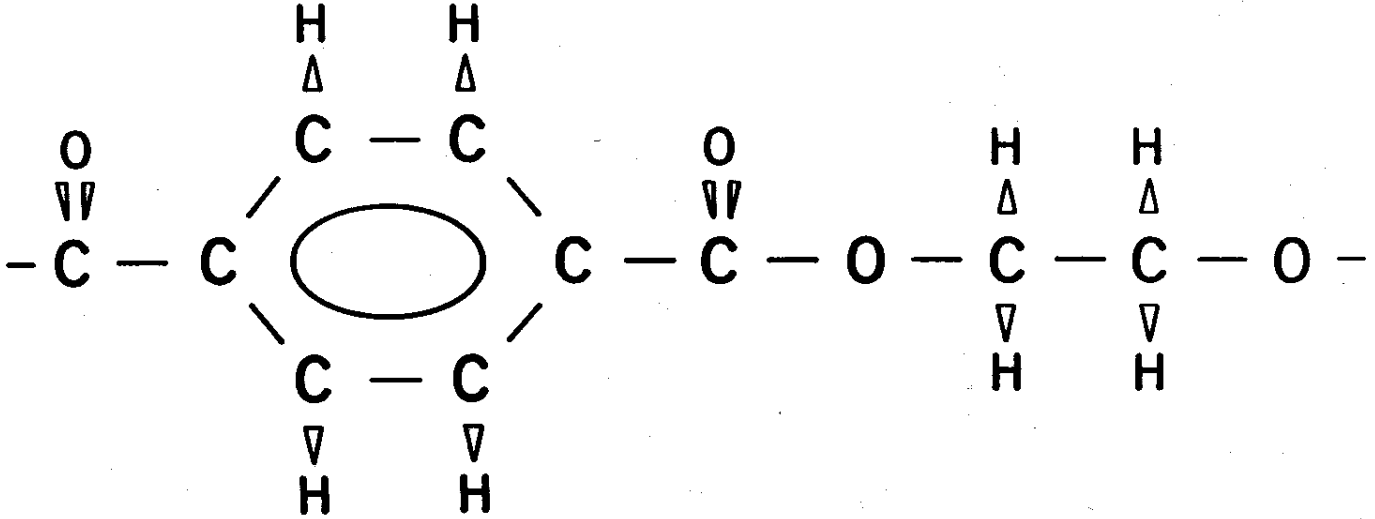
Typical space-charge electret polymers (fluoroethylenepropylene copolymer, polyimide, polyethyleneterephthalate, cycloolefin copolymer, polypropylene) and some properties

Name	Acronym	Density	Melting/Degrad.	Permittivity	Resistivity	Elasticity
Teflon	FEP	2.15 Mg/m ³	≈ 270 °C	2.0 ε ₀	> 10 ¹⁶ Ωm	480 MPa
Kapton	PI	1.42 Mg/m ³	(>400 °C)	>3.0 ε ₀	> 10 ¹⁵ Ωm	2.5 GPa
Mylar	PETP	1.39 Mg/m ³	≈ 255 °C	3.3 ε ₀	≈ 10 ¹⁶ Ωm	4.8 GPa
Topas	COC	1.02 Mg/m ³	≈ 260 °C	2.35 ε ₀	> 10 ¹⁴ Ωm	3.2 GPa
<i>many</i>	PP	0.91 Mg/m ³	≈ 165 °C	2.2 ε ₀	> 10 ¹⁶ Ωm	1.8 GPa

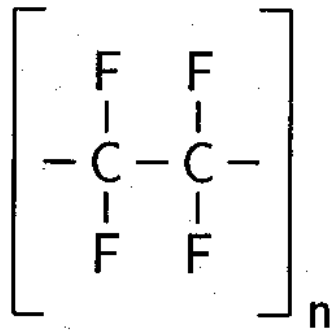
Note: Names are usually protected as registered trademarks and vary from manufacturer to manufacturer. Only one typical trade name for each electret polymer is given here.

Chemical formula of polyethylene terephthalate (PETP or PET)

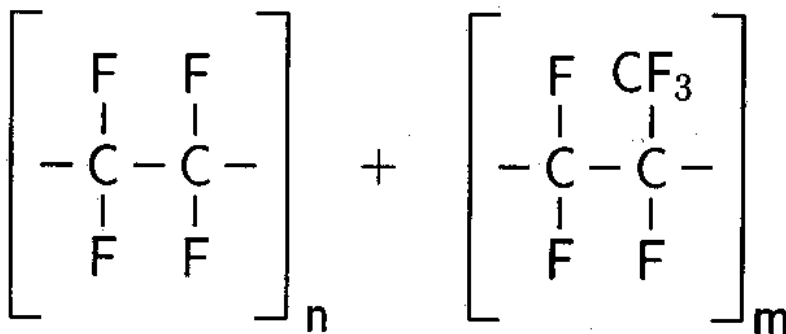
Trade names: Mylar, Hostaphan, Terphane, Melinex, etc.



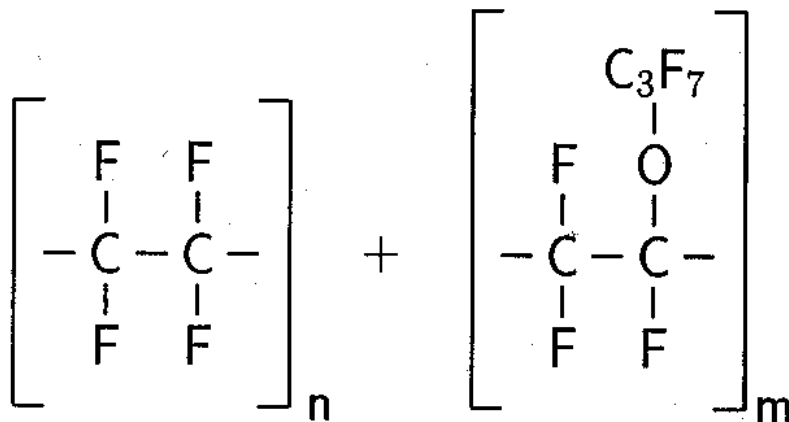
Teflon Fluoropolymers for Space-Charge Electrets



Polytetrafluoroethylene (Teflon PTFE)

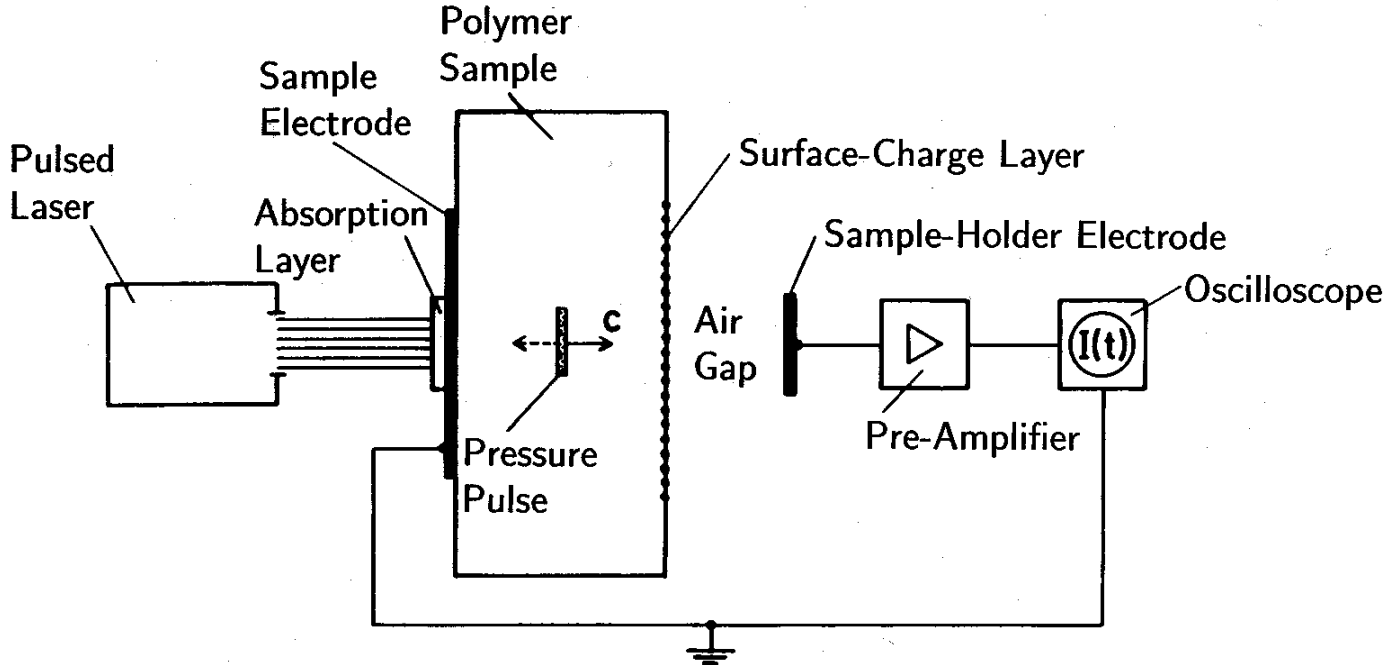


Tetrafluoroethylene-co-hexafluoropropylene
(Fluoroethylenepropylene, Teflon FEP)



Tetrafluoroethylene-co-perfluoropropoxyethylene
(Perfluoroalkoxy, Teflon PFA)

Laser-Induced Pressure Pulses (LIPPs) for probing charge and polarization-gradient profiles in polymer films



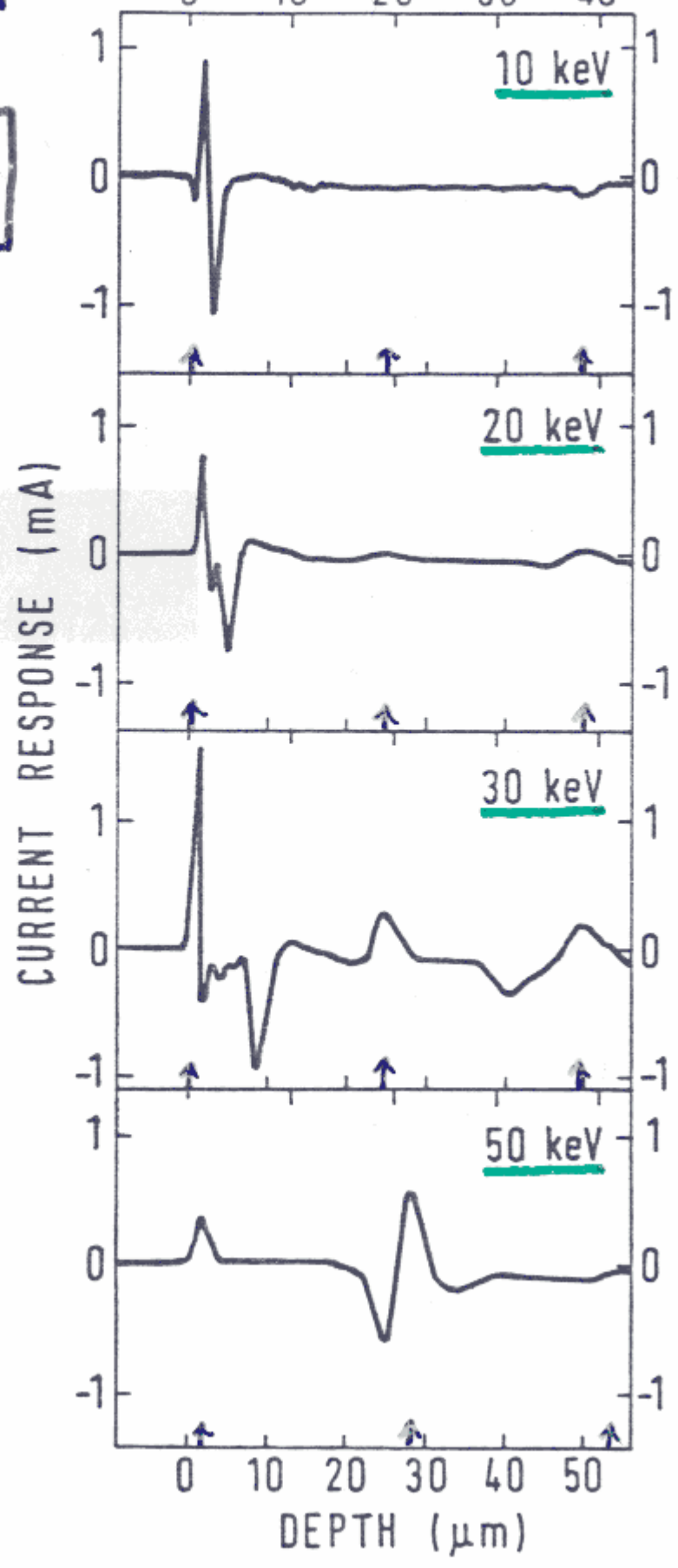
1.) e^- -Beams \rightarrow



2.) LIPP \rightarrow

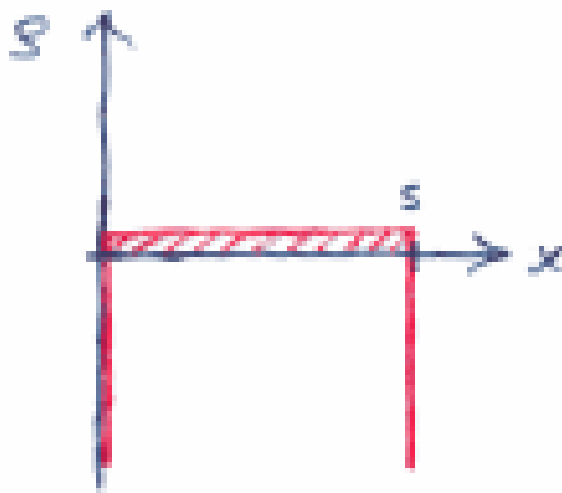


TIME (ns) **Teflon FEP**
25 μ m

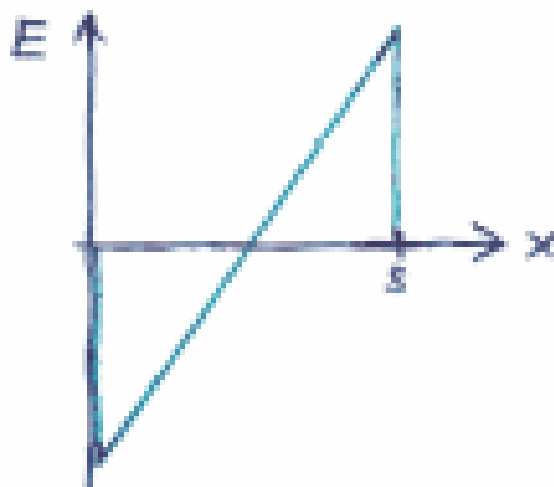


Uniform Volume-Charge Distributions

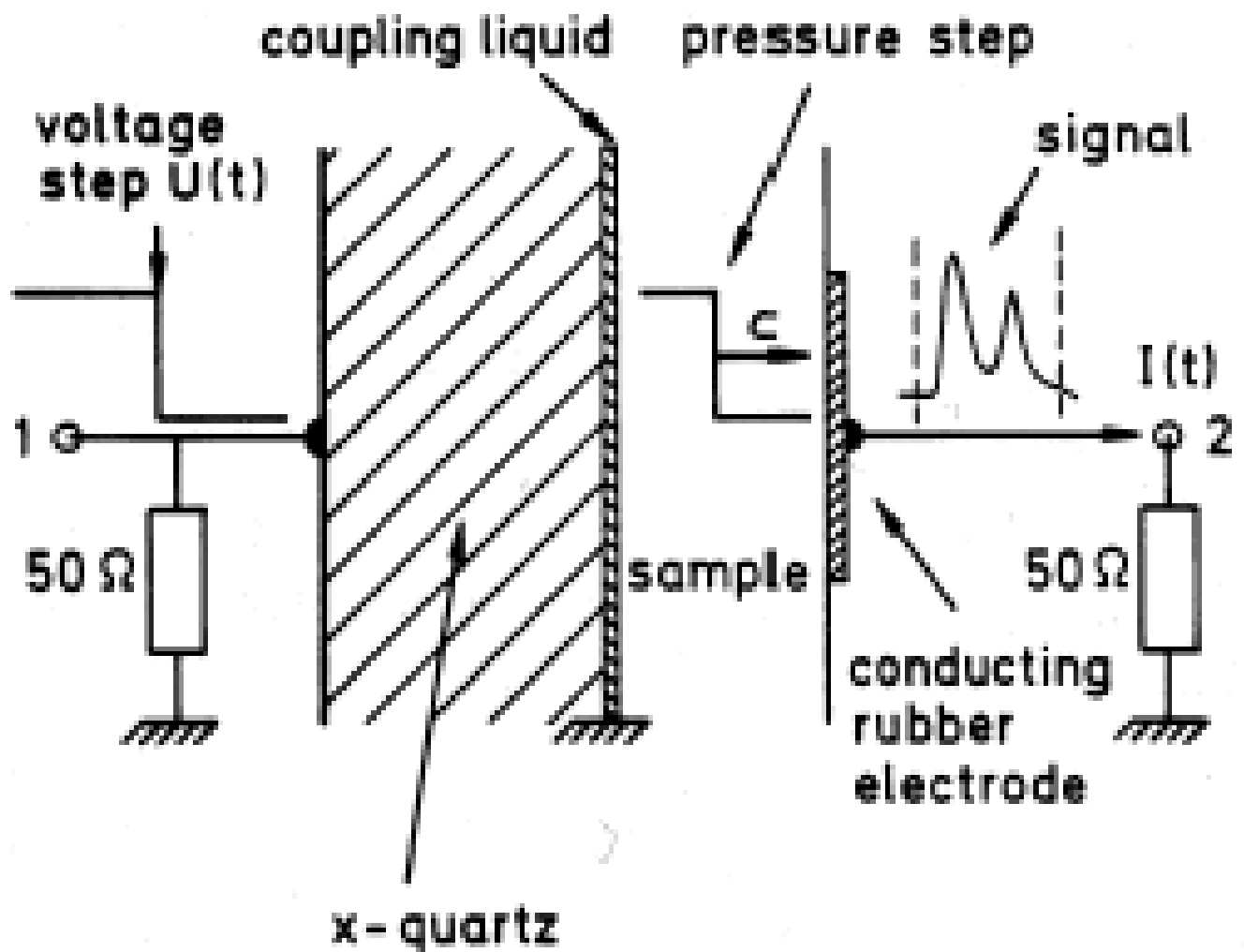
- in Pressure-Pulse Experiments
($I(t) \sim \rho(x)$; e.g. LPP)



- in Pressure-Step Experiments
($I(t) \sim E(x) \sim \int \rho(x) dx$; e.g. PPS)



Piezoelectrically Generated Pressure Steps for the Detection of Electric-Field Profiles

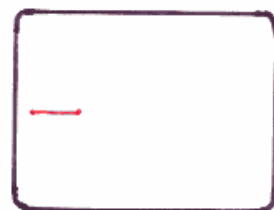
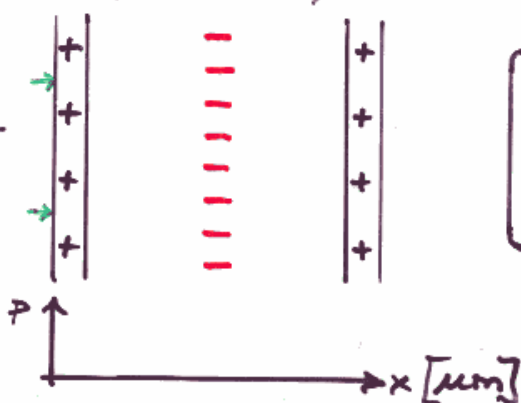


$$\begin{aligned}
 I(t) &= \frac{A_p}{\rho_0 c s} (\gamma + 1) \int_0^{x=ct} \rho(\xi) d\xi \\
 &= \frac{A_p}{\rho_0 c s} (\gamma + 1) \epsilon_0 \epsilon E(x = ct)
 \end{aligned}$$

Polymer-film geometry

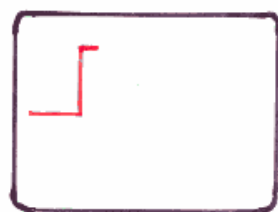
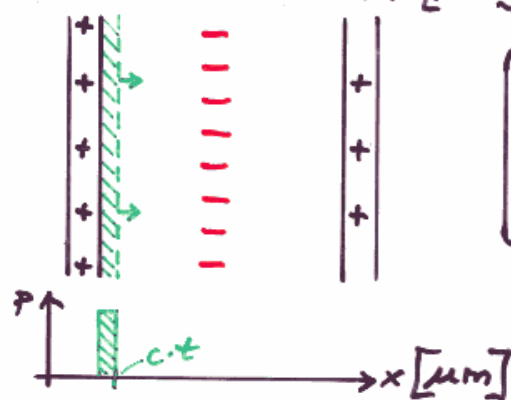
Short-circuit current

Pressure Step
about to enter
the sample



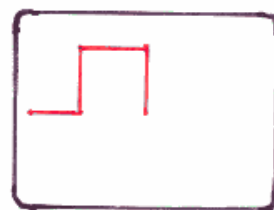
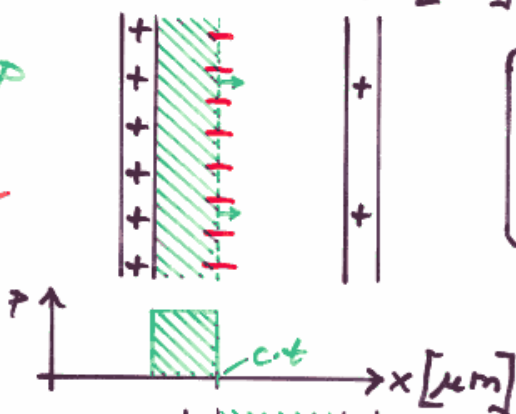
ns scale

Pressure Step
just inside
the sample



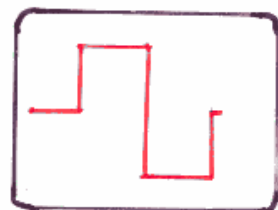
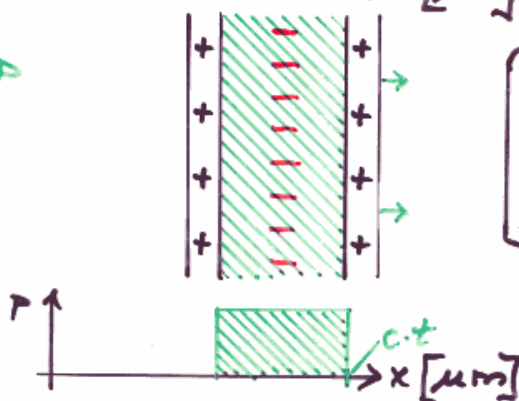
ns scale

Pressure Step
passing the
charge layer



ns scale

Pressure Step
leaving
the sample



ns scale

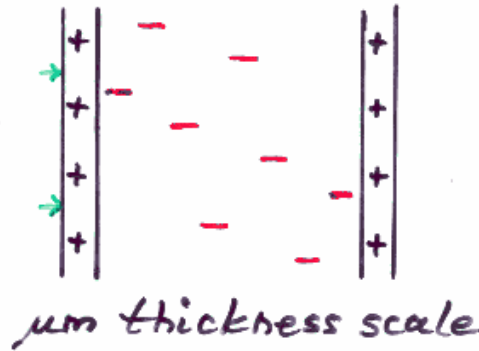
(Thickness change
exaggerated)

Oscilloscope
image

Polymer-film geometry

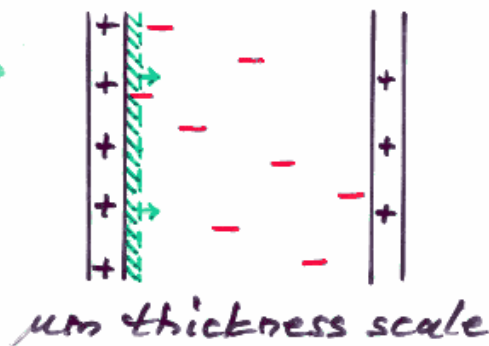
Short-circuit current

Pressure Step
about to enter
the sample



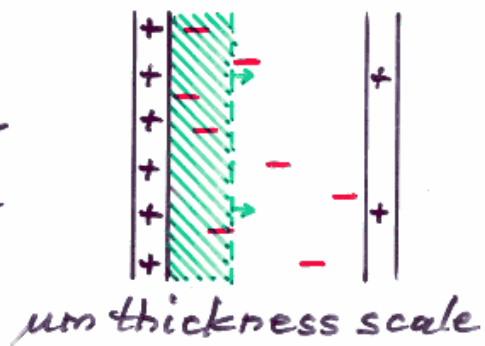
ns time scale

Pressure Step
just inside
the sample



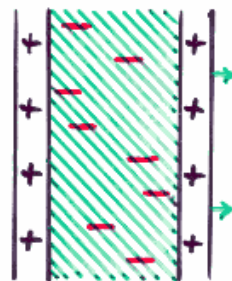
ns time scale

Pressure Step
at the center
of the sample

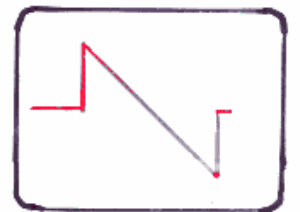


ns time scale

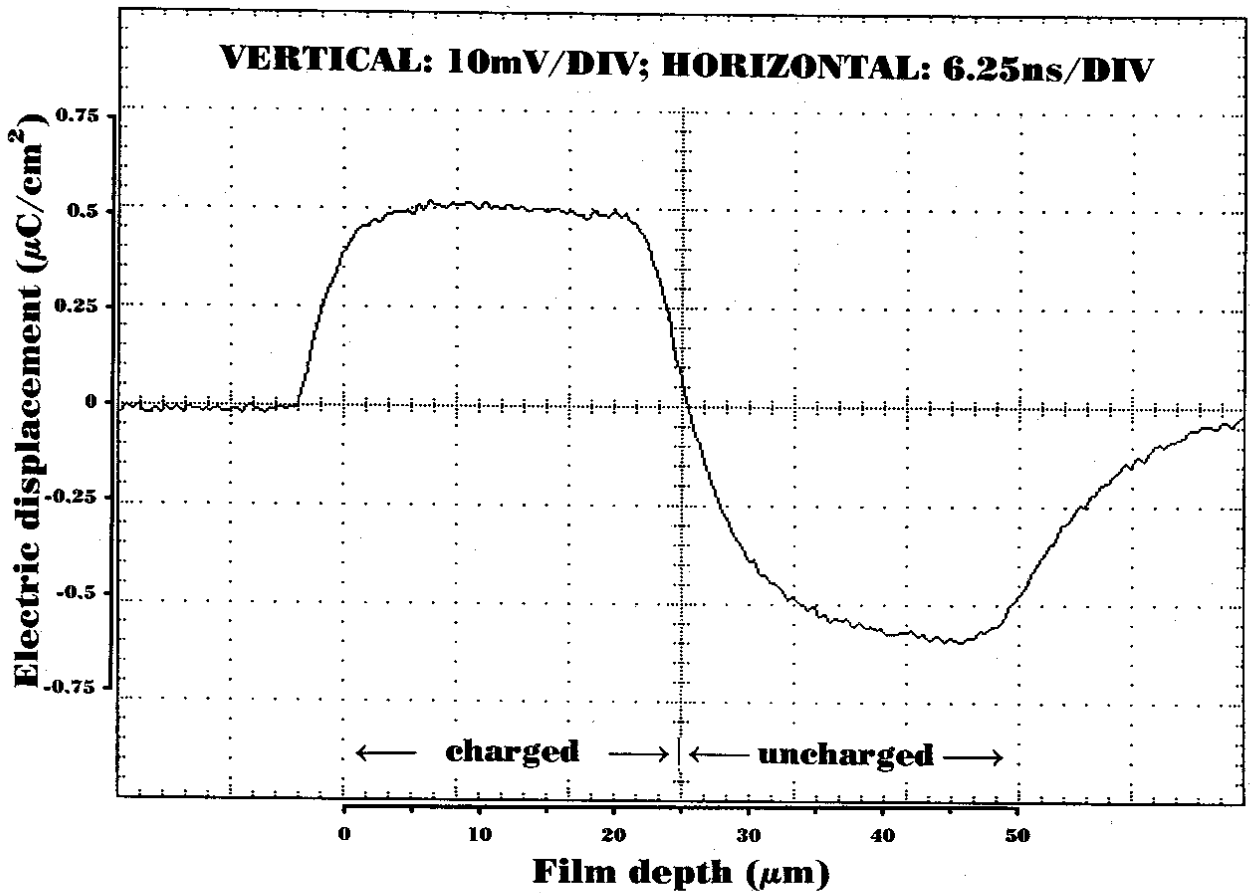
Pressure Step
leaving
the sample



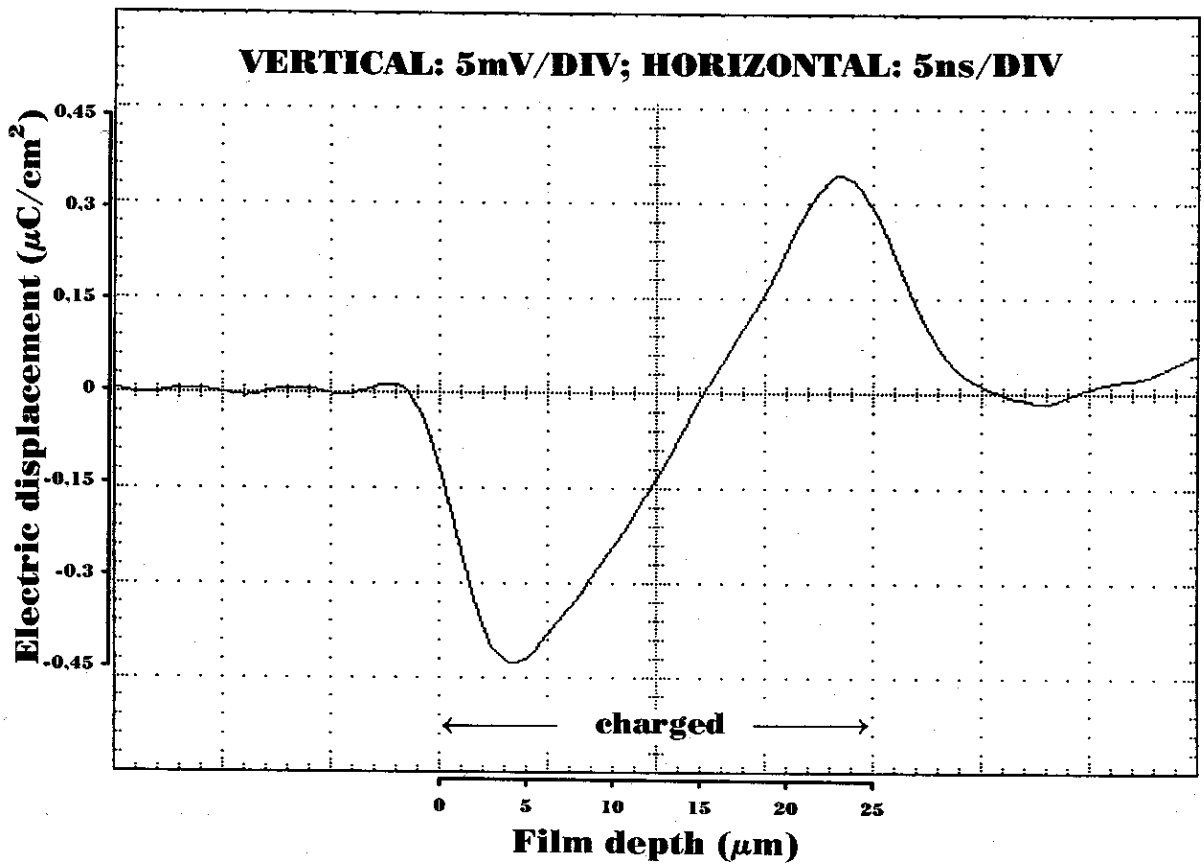
(Thickness change
exaggerated)



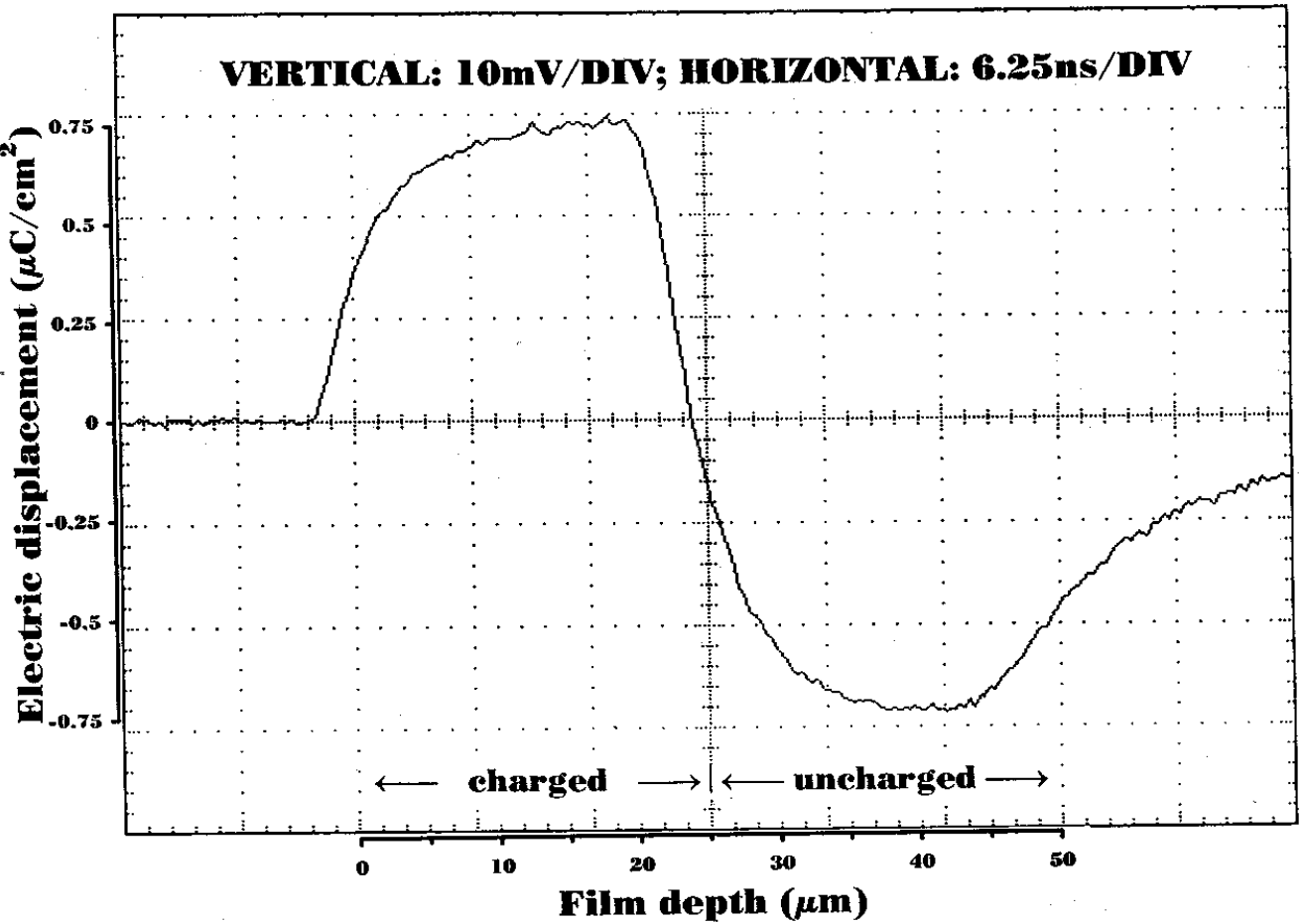
Oscilloscope
image



Electric-displacement profile in negatively corona-charged Teflon FEP ($V_c = -15$ kV, $T_c = 20^\circ\text{C}$, $t_c = 60$ min, maximum charge density ≈ 1600 C/m³)

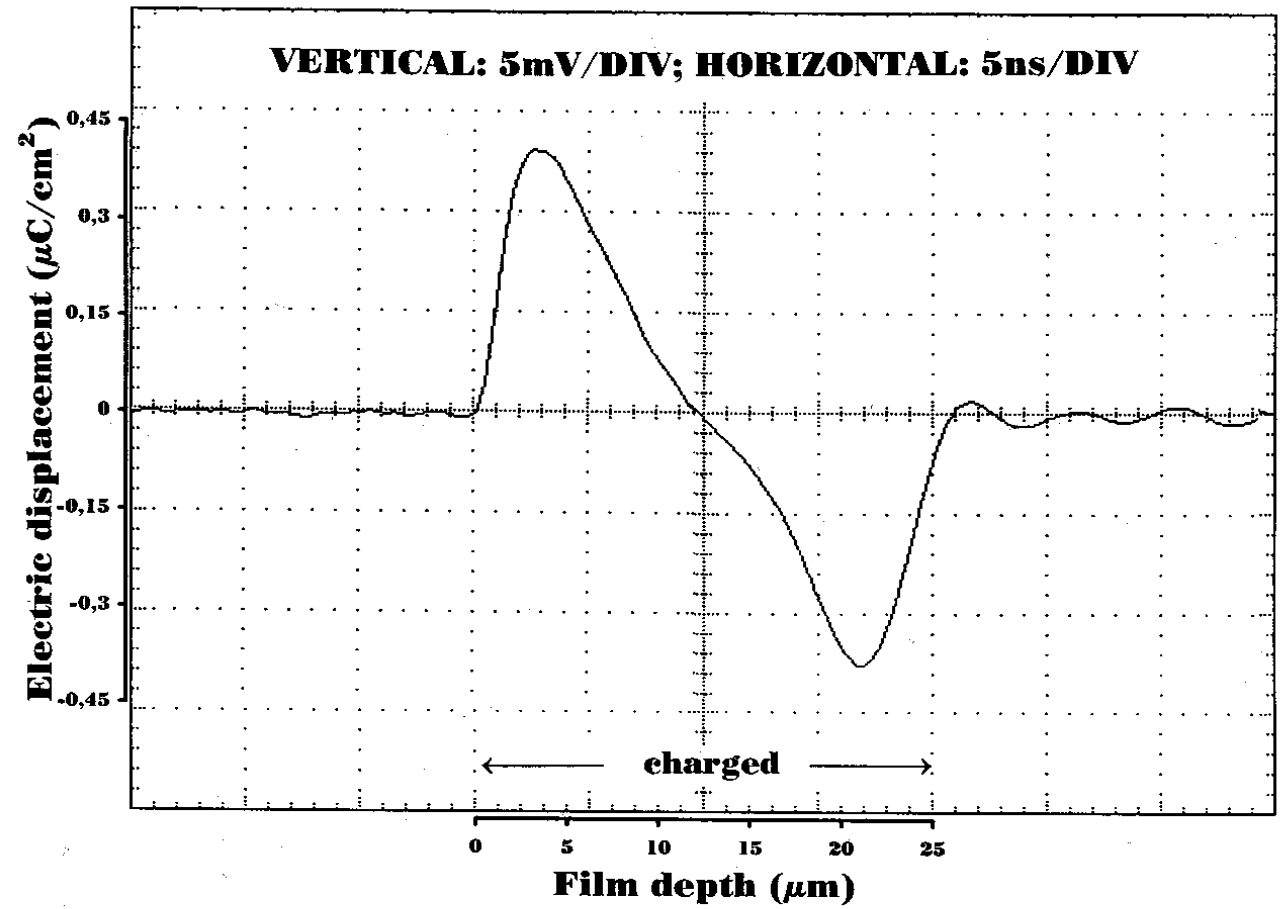


Electric-displacement profile in positively corona-charged Teflon PFA ($V_c = -15$ kV, $T_c = 200^\circ\text{C}$, $t_c = 60$ min, maximum charge density ≈ 500 C/m³)



Electric-displacement profile in negatively corona-charged Teflon PFA
($V_c = -15$ kV, $T_c = 20^\circ\text{C}$, $t_c = 60$ min, maximum charge density ≈ 2000 C/m³)

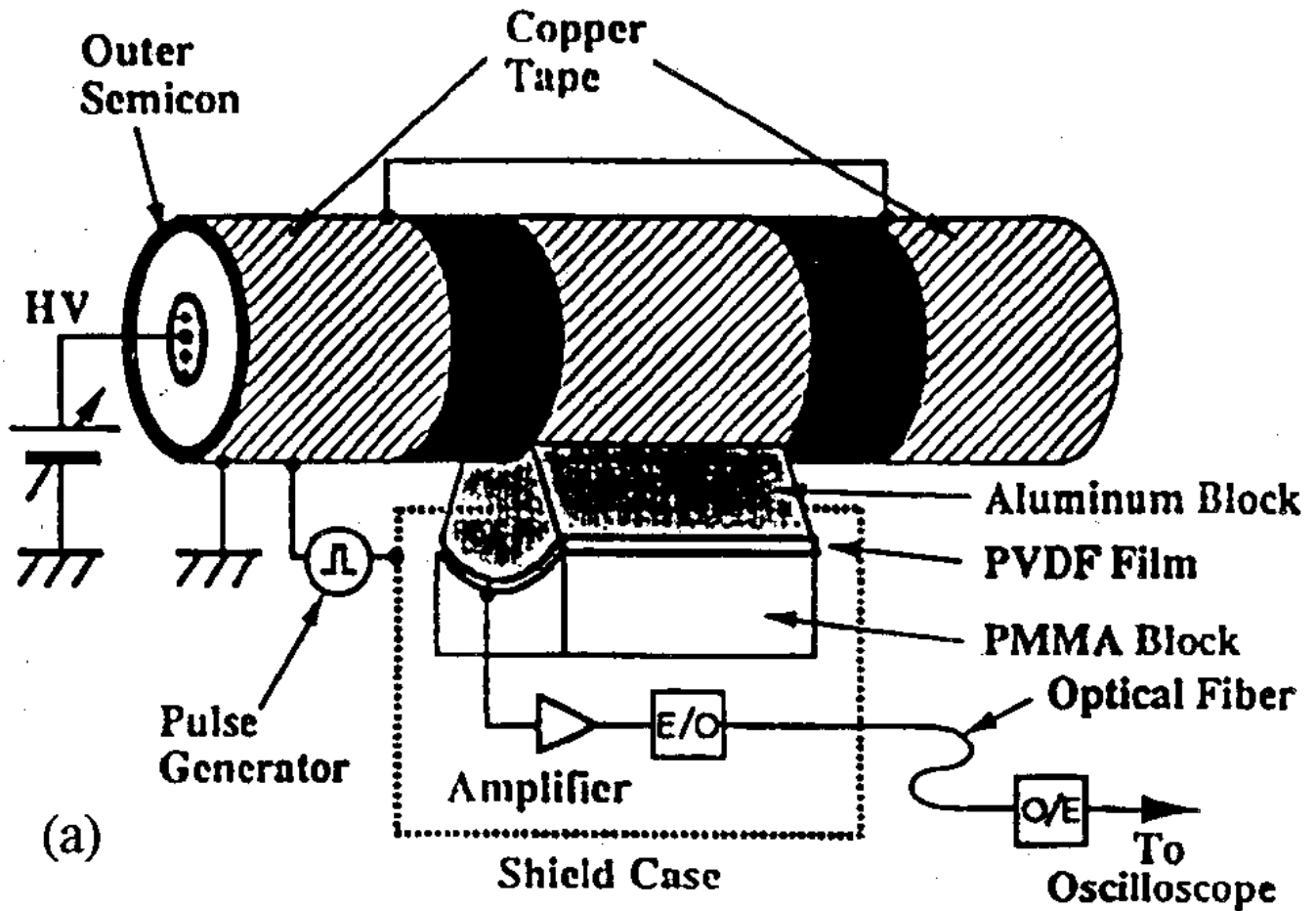
VERTICAL: 5mV/DIV; HORIZONTAL: 5ns/DIV



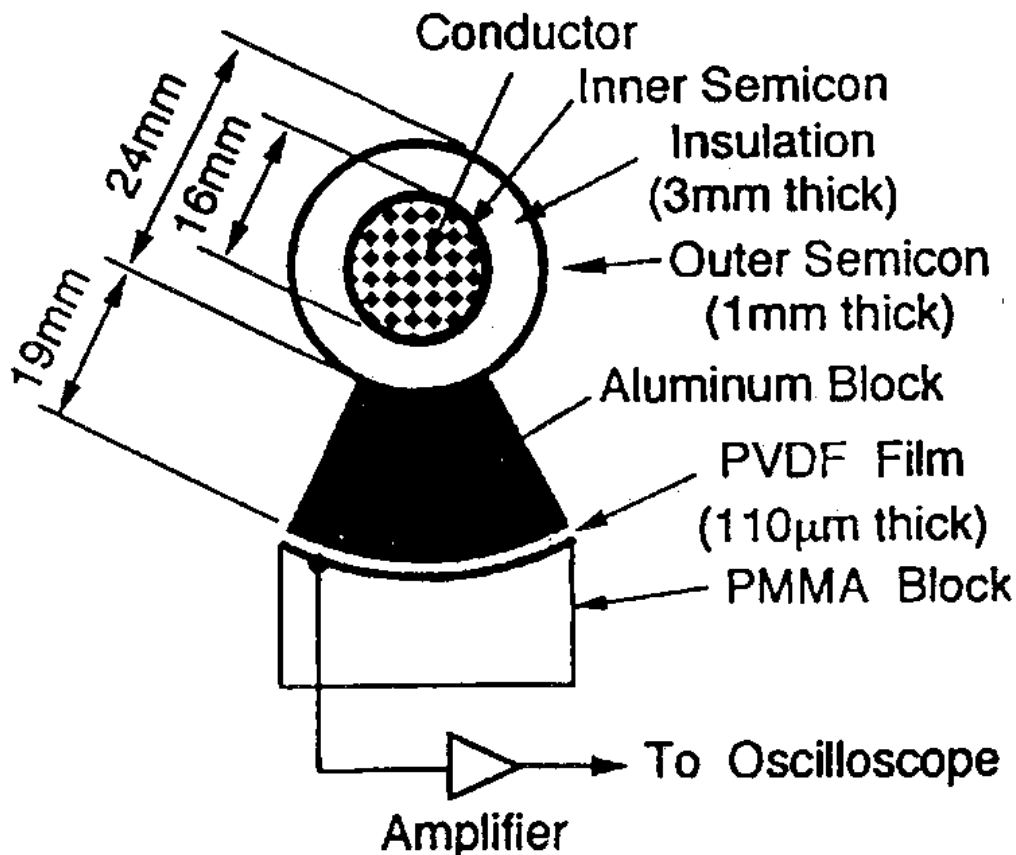
Electric-displacement profile in negatively corona-charged Teflon FEP ($V_c = -15$ kV, $T_c = 200^\circ\text{C}$, $t_c = 60$ min, maximum charge density ≈ 500 C/m³)

Side view (a) and cross section (b) of special PEA equipment for *in-situ* measurements on HV cables

(after Hozumi *et alii* 1994)



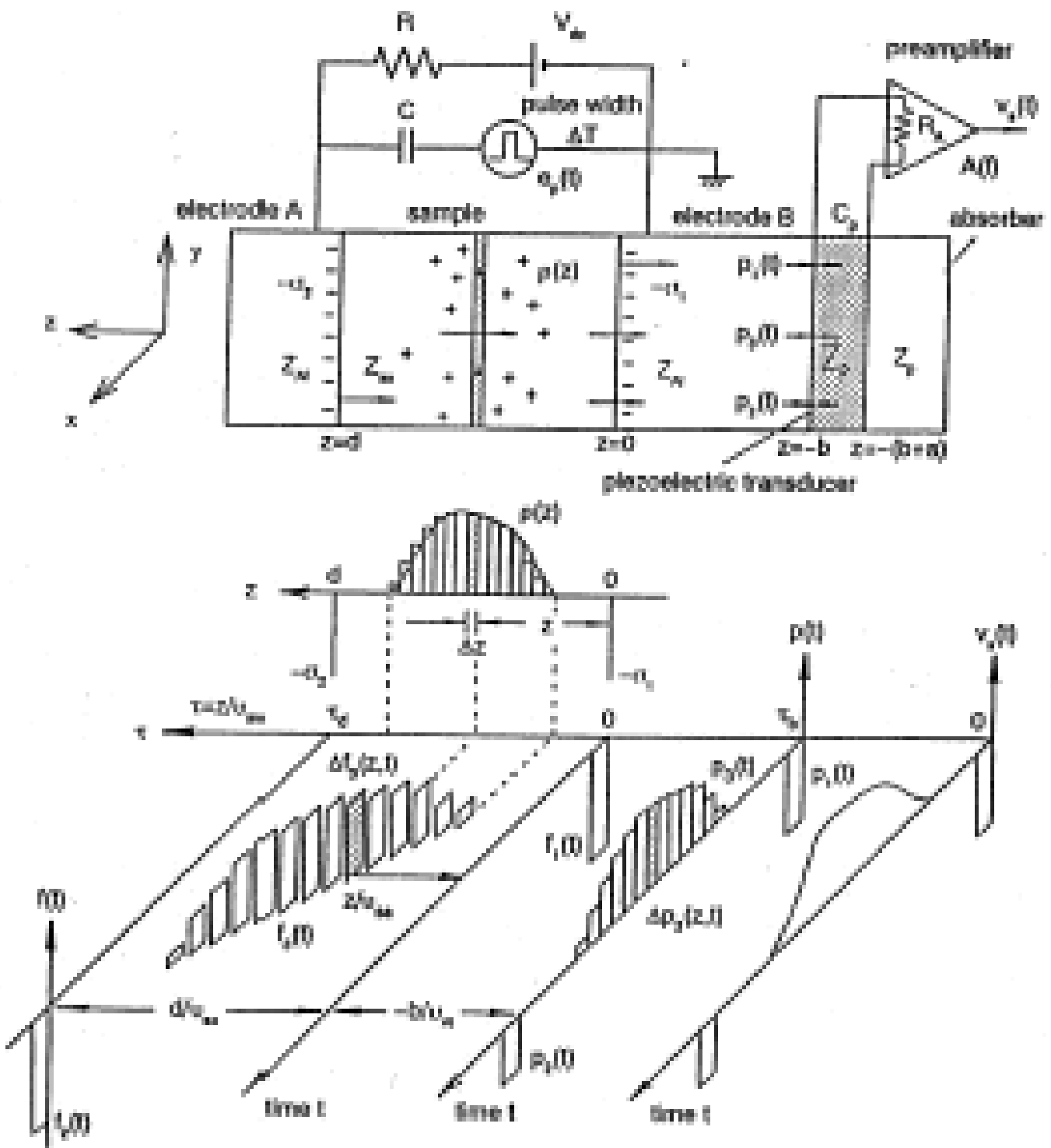
(a)



(b)

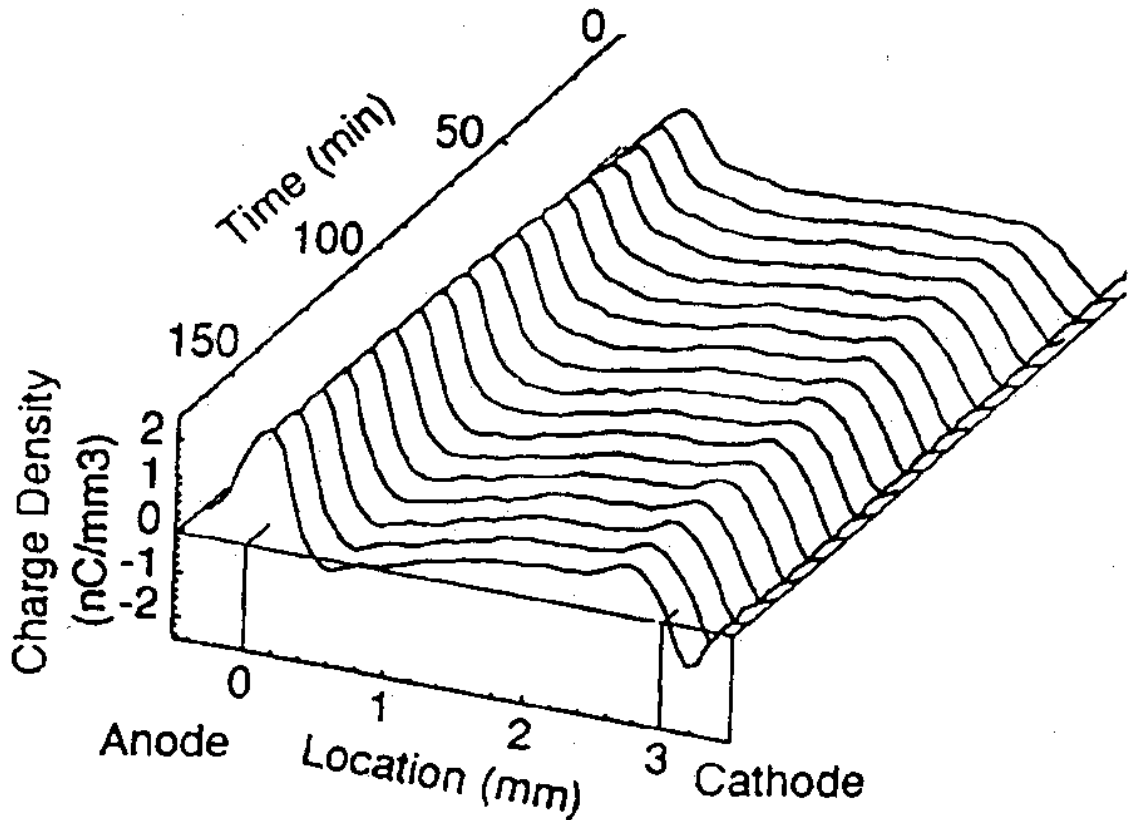
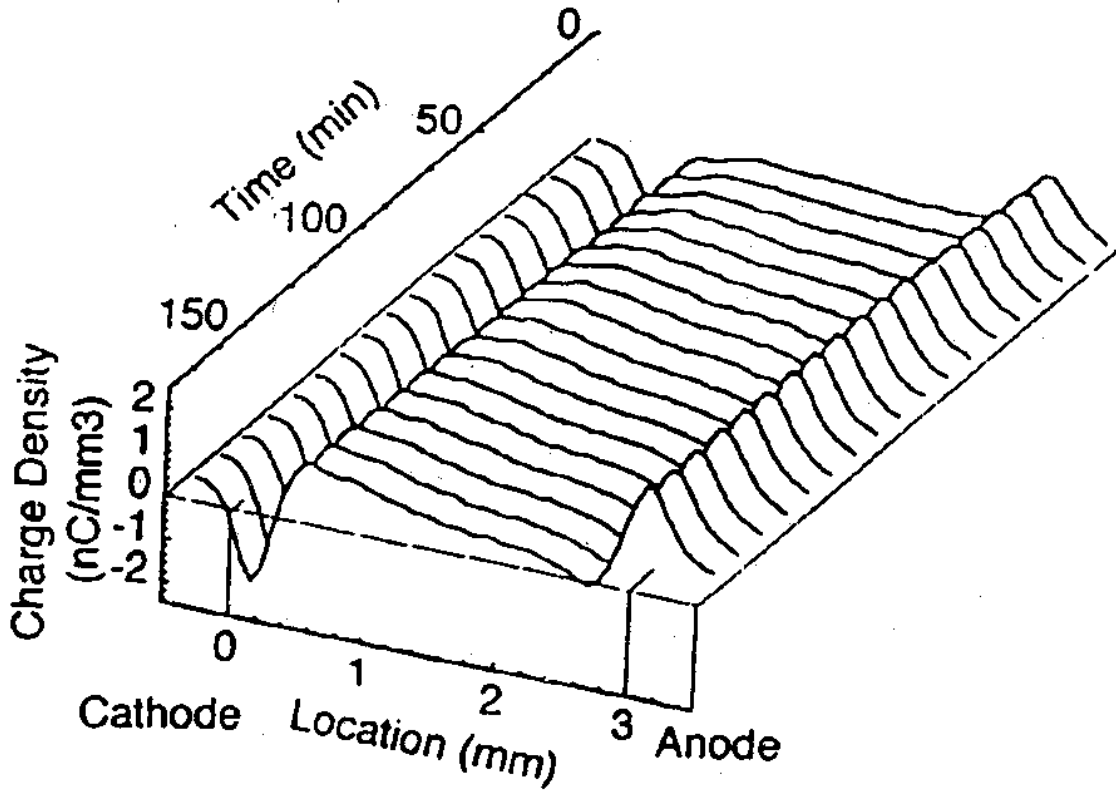
"Pulsed electroacoustic" (PEA) method for the measurement of charge distributions in dielectrics

(after Takada and Li 1992)



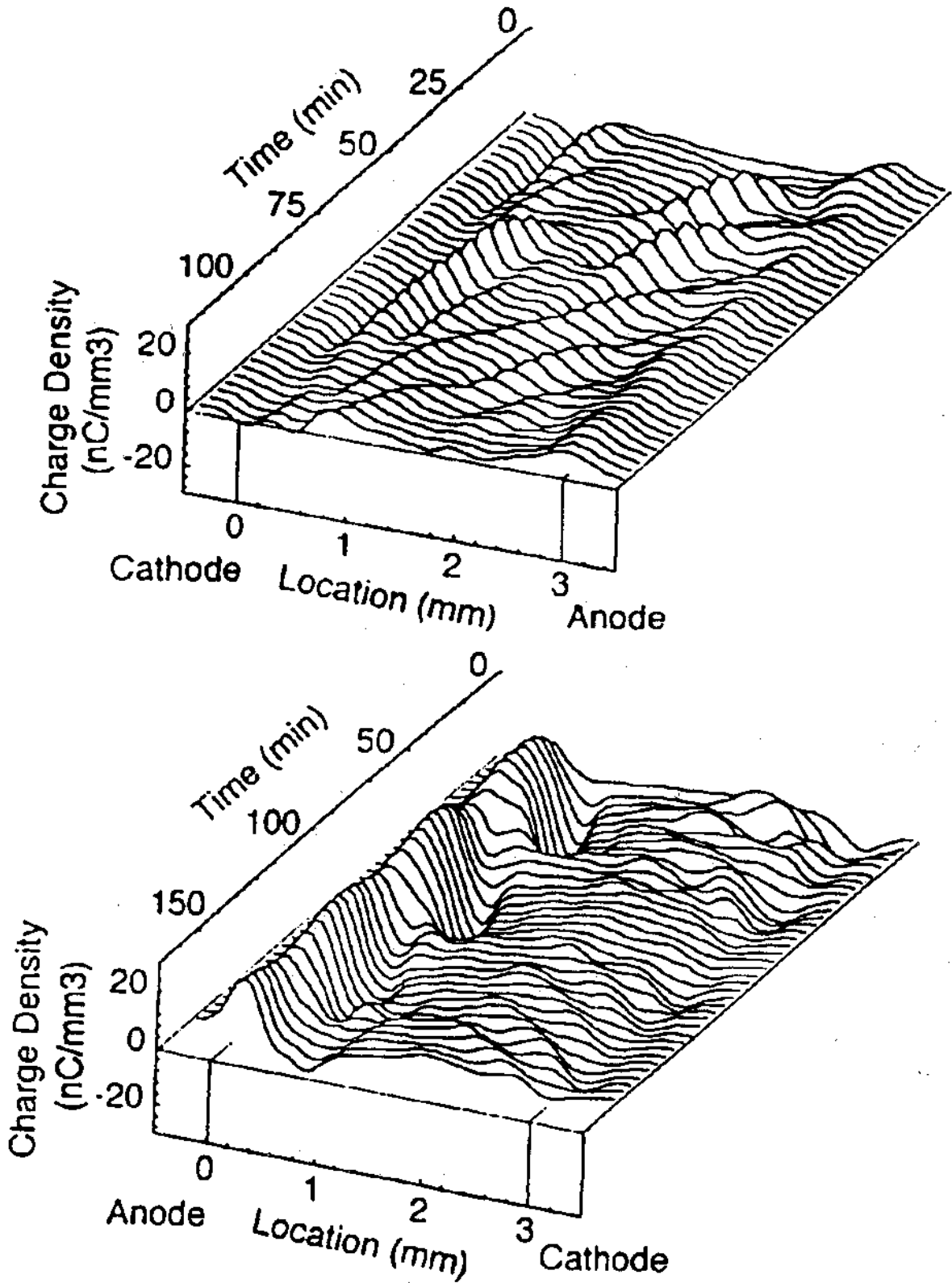
Development of the space-charge distributions in a high-voltage cable during application of $\pm 70\text{kV}$

(after Hozumi *et alii* 1994)



Development of the space-charge distributions in a high-voltage cable during application of $\pm 350\text{kV}$

(after Hozumi *et alii* 1994)



The 6 most relevant schemes for non-destructive probing of space charge in electret films

Probing technique	Mechanism of operation	Excitation mechanisms	Detection of signal	Spatial resolution
Thermal pulse	Time-dependent non-uniform expansion	Light flash or pulsed laser	Voltage with oscilloscope	depends on depth
Thermal step	Time-dependent non-uniform expansion	Heat reservoirs or continuous laser	Voltage with oscilloscope	depends on depth
Thermal wave	Frequency-dependent periodic expansion	Chopped light or modulated laser	Current/voltage with lock-in amp.	depends on freq.
Acoustic pulse	Propagation of thin compression zone	Piezo-transducer or pulsed laser	Current via 50Ω with oscilloscope	$\geq 1\mu\text{m}$
Acoustic step	Propagation of steep compression front	Cable discharge + piezo-transducer	Current via 50Ω with oscilloscope	$\geq 1\mu\text{m}$
Acoustic wave	Propagation of field-induced acoustic wave	Electric pulse on electrodes	Piezo-transducer + oscilloscope	depends on pulse

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Response Equations for the Probing of Charge and Polarization Profiles in Thin Dielectrics by Non-Uniform Temperature or Stress Excitation

Total current density inside the sample:

$$i(t) = \rho_r(x, t)v(x, t) + \frac{\partial D(x, t)}{\partial t} \quad \text{with} \quad D(x, t) = \varepsilon_0\varepsilon(x, t)E(x, t) + P(x, t)$$

General response equation ($T \equiv$ temperature or stress):

$$I(t) = \frac{A}{s} \int_0^s \left[\left(\frac{1}{\varepsilon} \frac{d\varepsilon}{dT} - \frac{1}{x} \frac{dx}{dT} \right) \varepsilon_0\varepsilon E(x) + \frac{dP(x)}{dT} \right] \frac{\partial T(x, t)}{\partial t} dx$$

Response equation for thermal excitation (e.g. heat pulse):

$$I(t) = \frac{A}{s} \int_0^s [(\alpha_\varepsilon - \alpha_x)\varepsilon_0\varepsilon E(x) + \lambda(x)] \frac{\partial T(x, t)}{\partial t} dx$$

Response equation for mechanical excitation (e.g. pressure pulse):

$$I(t) = \frac{A}{s} \int_0^s [-(\gamma + 1)\varepsilon_0\varepsilon E(x) + e_{33}(x)] \chi \frac{\partial p(x, t)}{\partial t} dx$$

Response Equations for Specific Experimental Probing Techniques

Laser-Intensity Modulation Method (LIMM) (Lang and Das-Gupta 1981)

$$I(t) = \frac{A}{s} \int_0^x [(\alpha_c - \alpha_x) \int_0^x \rho_r(\xi) d\xi + (\alpha_P + \alpha_x - \alpha_c) P(x)] \frac{\partial T(x, t)}{\partial t} dx$$

Thermal Pulsing Technique (Collins 1975)

$$\Delta V(t) = \int_0^x \left[\frac{\alpha_c - \alpha_x}{\epsilon_0 \epsilon} \int_0^x \rho_r(\xi) d\xi + \frac{\alpha_P + \alpha_x - \alpha_c}{\epsilon_0 \epsilon} P(x) \right] \Delta T(x, t) dx$$

Laser-Induced Pressure-Pulse (LIPP) Technique

(Sessler, West and Gerhard-Multhaupt 1981)

$$I(t) = \frac{A p \tau}{\rho_0 s} \left[(\gamma + 1) \epsilon_0 \epsilon \rho(x) - \frac{de_{33}(x)}{dx} \right]_{x=ct}$$

Piezoelectrically Generated Pressure-Step (PPS) Method

(Eisenmenger and Haardt 1982)

$$I(t) = \frac{A p}{\rho_0 c s} [(\gamma + 1) \int_0^x \rho(\xi) d\xi - e_{33}(x)]_{x=ct}$$

Conclusions and outlook

- Space charge (i.e. *extra* charge) provides external electric field for applications
- Good charge retention related to excellent insulation properties and high thermal stability
- A few special polymers (plus some inorganic materials) highly suitable for electrets

- Non-destructive space-charge probing with acoustic-wave (pressure) propagation or thermal-wave (heat) diffusion possible
- Space-charge stability possibly a combination of deep (chemical) trapping on macromolecule and restricted (physical) mobility of macromolecules